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ON Semiconductor NTMS4807NR2G

For any questions, you can email us directly: sales@integrated-circuit.com



NTMS4807N

Power MOSFET 30 V, 14.8 A, N-Channel, SO-8

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- This is a Pb-Free Device

Applications

- Disk Drives
- DC-DC Converters
- Printers

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V_{DSS}	30	V
Gate-to-Source Voltage	Gate-to-Source Voltage			±20	V
Continuous Drain		T _A = 25°C	I _D	12.2	Α
Current R _{θJA} (Note 1)		T _A = 70°C		9.8	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	1.55	W
Continuous Drain		T _A = 25°C	Ι _D	9.1	Α
Current R _{θJA} (Note 2)	Steady	T _A = 70°C		7.3	
Power Dissipation $R_{\theta JA}$ (Note 2)	State	T _A = 25°C	P _D	0.86	W
Continuous Drain		T _A = 25°C	I _D	14.8	Α
Current $R_{\theta JA}$, $t \le 10 s$ (Note 1)		T _A = 70°C		11.8	
Power Dissipation $R_{\theta JA}$, $t \le 10 \text{ s(Note 1)}$		T _A = 25°C	P _D	2.3	W
Pulsed Drain Current	Pulsed Drain Current $T_A = 25^{\circ}C$, $t_p = 10 \mu s$			50	Α
Operating Junction and Storage Temperature			T _J , T _{stg}	-55 to 150	°C
Source Current (Body Diode)			I _S	2.9	Α
Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25$ °C, $V_{DD} = 30$ V, $V_{GS} = 10$ V, $I_L = 14$ A _{pk} , $L = 1.0$ mH, $R_G = 25$ Ω)			E _{AS}	98	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			TL	260	°C

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Ambient - Steady State (Note 1)	$R_{\theta JA}$	80.5	°C/W
Junction-to-Ambient – $t \le 10 \text{ s (Note 1)}$	$R_{\theta JA}$	54.9	
Junction-to-Foot (Drain)	$R_{\theta JF}$	19.5	
Junction-to-Ambient - Steady State (Note 2)	$R_{\theta JA}$	145	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

1. Surfacemounted on FR4 board using 1 in sq pad size.

2. Surfacemounted on FR4 board using the minimum recommended pad size.

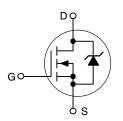


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX	
30 V	6.1 mΩ @ 10 V	14.8 A	
	7.5 m Ω @ 4.5 V	14.0 A	

N-Channel





MARKING DIAGRAM/ PIN ASSIGNMENT

□ Drain

Source -Source -Gate □ Drain STYLE 12

> 4807N = Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTMS4807NR2G	SO-8 (Pb-Free)	2500/Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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Datasheet of NTMS4807NR2G - MOSFET N-CH 30V 9.1A 8-SOIC

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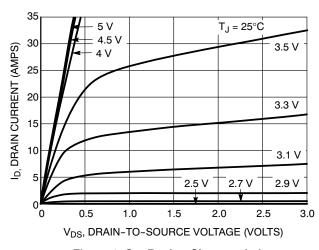
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS		•			•		
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				29		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}		T _J = 25°C			1.0	μΑ
		V _{GS} = 0 V, V _{DS} = 24 V	T _J = 100°C			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 2$	250 μΑ	1.5		3.0	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V, I _D =	14.8 A		5.1	6.1	$m\Omega$
		V _{GS} = 4.5 V, I _D =	= 12 A		6.5	7.5	1
Forward Transconductance	9FS	V _{DS} = 1.5 V, I _D =	14.8 A		16		S
CHARGES, CAPACITANCES AND G.	ATE RESISTAN	NCE					
Input Capacitance	C _{iss}				2900		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MHz	, V _{DS} = 24 V		562		
Reverse Transfer Capacitance	C _{rss}	1			307		
Total Gate Charge	Q _{G(TOT)}				24		nC
Threshold Gate Charge	Q _{G(TH)}	1			3.4		
Gate-to-Source Charge	Q _{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}$	/, I _D = 14.8 A		7.7		
Gate-to-Drain Charge	Q_{GD}	1	ŀ		10.4		1
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 15 V, I _D = 14.8 A			46		nC
SWITCHING CHARACTERISTICS (N	ote 4)					•	•
Turn-On Delay Time	t _{d(on)}				14		ns
Rise Time	t _r	V _{GS} = 10 V, V _{DS} =	= 15 V.		6.5		
Turn-Off Delay Time	t _{d(off)}	I _D = 1.0 A, R _G =	6.0 Ω΄		47		
Fall Time	t _f	1	•		17		
DRAIN-SOURCE DIODE CHARACTE	RISTICS					•	•
Forward Diode Voltage	V_{SD}		T _J = 25°C		0.75	1.0	V
		$V_{GS} = 0 \text{ V}, I_{S} = 2.9 \text{ A}$	T _J = 125°C		0.58		1
Reverse Recovery Time	t _{RR}	$V_{GS} = 0 \text{ V}, d_{IS}/d_t = 100 \text{ A}/\mu\text{s},$ $I_S = 2.9 \text{ A}$			30		ns
Charge Time	ta				15		1
Discharge Time	t _b				15		1
Reverse Recovery Charge	Q _{RR}				23		nC
PACKAGE PARASITIC VALUES	•				-	-	-
Source Inductance	L _S	T _A = 25°C			0.66		nH
Drain Inductance	L _D	T _A = 25°C			0.20		nH
Gate Inductance	L _G	T _A = 25°C			1.5		nH
Gate Resistance	R_{G}	T _A = 25°C			0.9	1.4	Ω

Pulse Test: pulse width = 300 μs, duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

NTMS4807N

TYPICAL PERFORMANCE CURVES



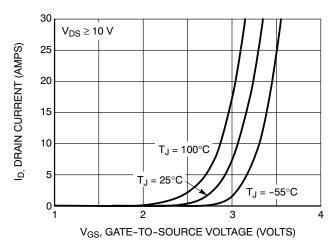
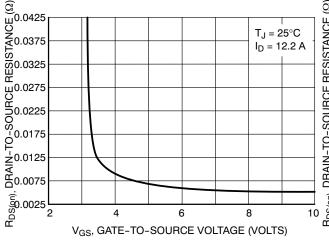


Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



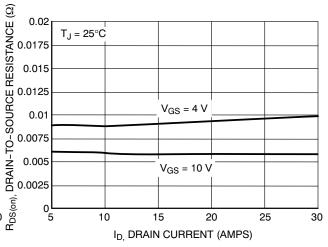
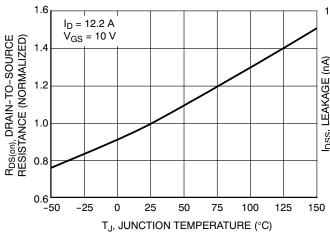


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



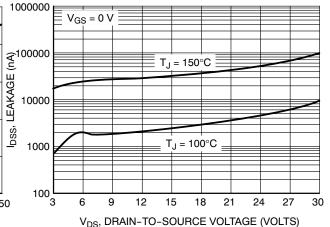


Figure 5. On-Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

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TYPICAL PERFORMANCE CURVES

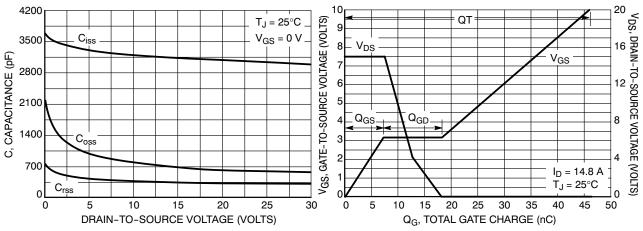


Figure 7. Capacitance Variation

Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge

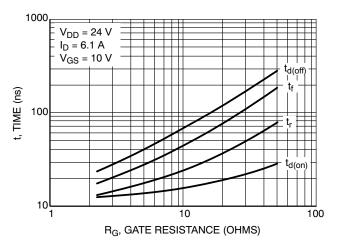


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

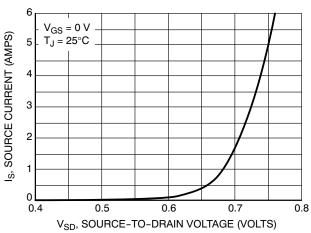


Figure 10. Diode Forward Voltage vs. Current

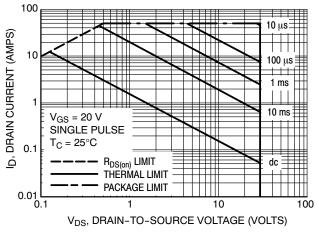


Figure 11. Maximum Rated Forward Biased Safe Operating Area

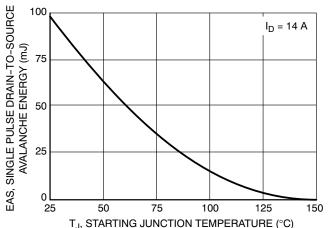


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature



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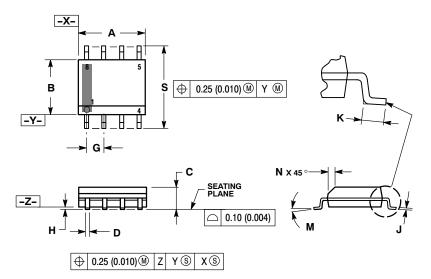
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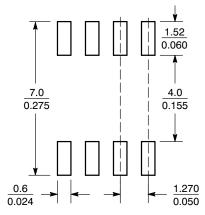
NTMS4807N

PACKAGE DIMENSIONS

SOIC-8 CASE 751-07 **ISSUE AJ**



SOLDERING FOOTPRINT*



(mm inches SCALE 6:1

NOTES

- NOTES:

 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

 2. CONTROLLING DIMENSION: MILLIMETER.

 3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.

 4. MAXIMUM MOLD PROTRUSION 0.15 (0.006)

- PER SIDE.
 DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT
- MAXIMUM MATERIAL CONDITION.
 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIMETERS		INCHES			
DIM	MIN MAX		MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80 4.00		0.150	0.157		
C	1.35 1.75		0.053	0.069		
D	0.33 0.51		0.013	0.020		
O	1.27	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010		
C	0.19	0.19 0.25		0.010		
K	0.40	0.40 1.27		0.050		
М	0	0 ° 8 °		8 °		
N	0.25	0.25 0.50		0.020		
'n	5.80 6.20		0.228	0.244		

STYLE 12:

SOURCE PIN 1.

- SOURCE
- 3. SOURCE
- GATE DRAIN 4. 5.
- DRAIN DRAIN
- DRAIN

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